

Resource Summary Report

Generated by T1D on Aug 10, 2026

JEOL: InfiTOF Multi-Turn Time-of-Flight Mass Spectrometer

RRID:SCR_020167

Type: Tool

Proper Citation

JEOL: InfiTOF Multi-Turn Time-of-Flight Mass Spectrometer (RRID:SCR_020167)

Resource Information

URL: <https://www.jeolusa.com/PRODUCTS/Mass-Spectrometers/InfiTOF>

Proper Citation: JEOL: InfiTOF Multi-Turn Time-of-Flight Mass Spectrometer (RRID:SCR_020167)

Description: Mass spectrometer that can determine elemental compositions for ions within range of m/z 1 to 1,000. Hydrogen ion H plus can be detected with multi turn and multi segment that obtains high resolution with small ion flight path design.

Resource Type: instrument resource

Keywords: Jeol, JEOL, Mass Spectrometer, Instrument, Equipment, USEDit

Availability: Commercially available

Resource Name: JEOL: InfiTOF Multi-Turn Time-of-Flight Mass Spectrometer

Resource ID: SCR_020167

Alternate IDs: Model_Number_InfiTOF

Record Creation Time: 20220129T080349+0000

Record Last Update: 20260808T190138+0000

Ratings and Alerts

No rating or validation information has been found for JEOL: InfiTOF Multi-Turn Time-of-Flight Mass Spectrometer.

No alerts have been found for JEOL: InfiTOF Multi-Turn Time-of-Flight Mass Spectrometer.

Data and Source Information

Source: [SciCrunch Registry](#)

Usage and Citation Metrics

We have not found any literature mentions for this resource.